



Effect of muon alignment on TeV tracks

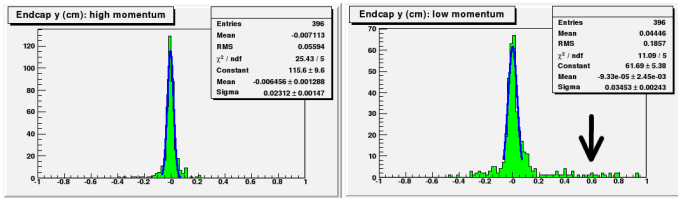
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Need for a bottom line

- ▶ We have seen that muon alignment needs surprisingly few tracks for $100\ \mu\text{m}$ accuracy RMS in x , but
 - ▶ some degrees of freedom better aligned than others
 - ▶ some distributions have tails, especially systematics studies

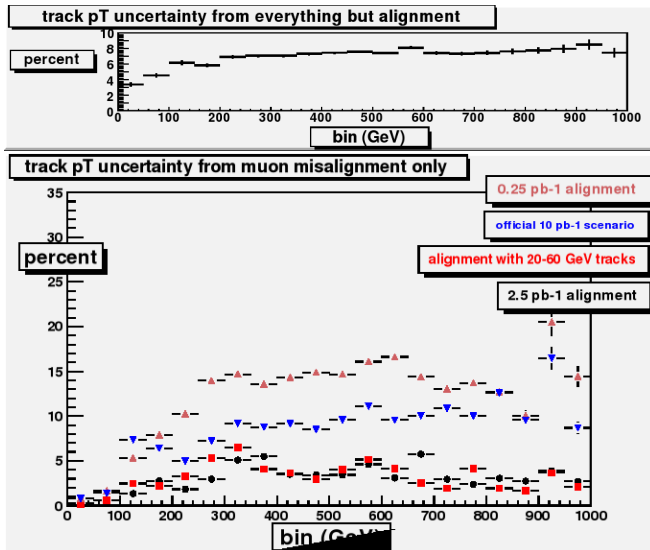


- ▶ To assess alignment quality, we can look at its effect on TeV-scale tracks
 - ▶ effect on momentum resolution for individual tracks
 - ▶ broadening of TeV di-muon resonance (RMS misalignment)
 - ▶ smearing of Drell-Yan background (higher moments)



Effect on individual tracks

Fractional widening of momentum distribution, binned



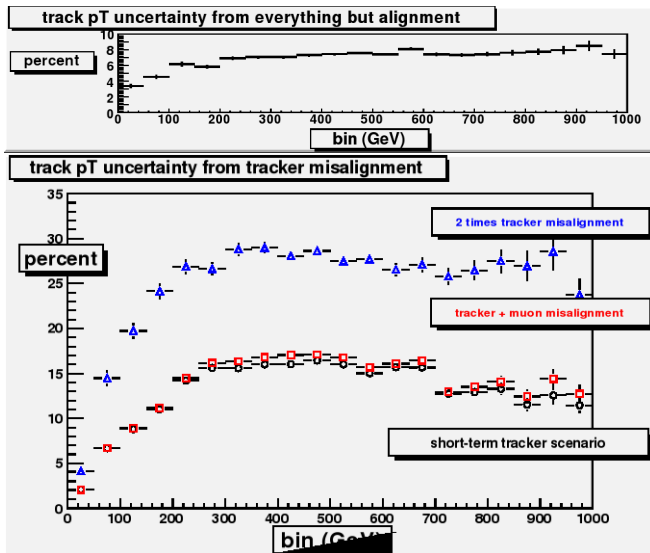
track-by-track RMS
of $\frac{p_{T\text{ideal}}}{p_{T\text{generated}}} - 1$

track-by-track RMS
of $\frac{p_{T\text{misaligned}}}{p_{T\text{ideal}}} - 1$

$$\left(\frac{\sigma_{p_T}}{p_T}\right) = \left(\frac{\sigma_{\kappa}}{\kappa}\right)$$

= sum in quadrature
of both uncertainties

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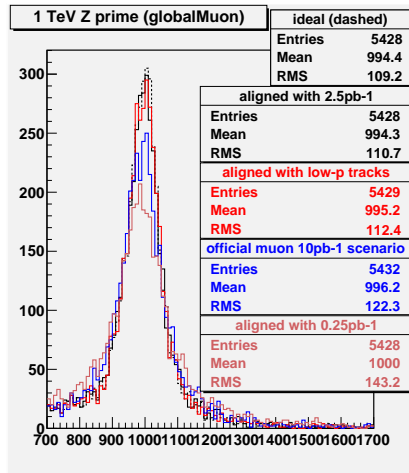
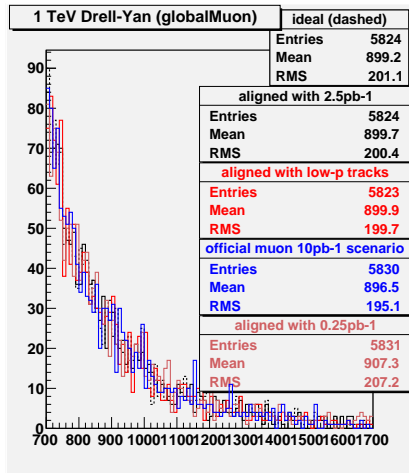
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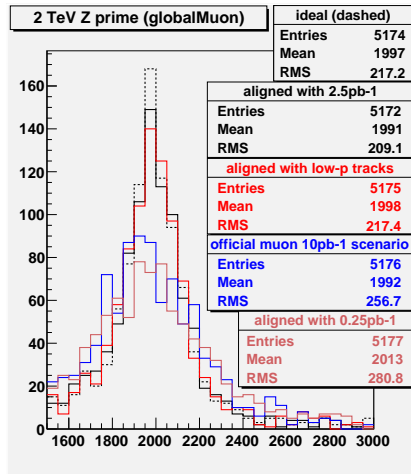
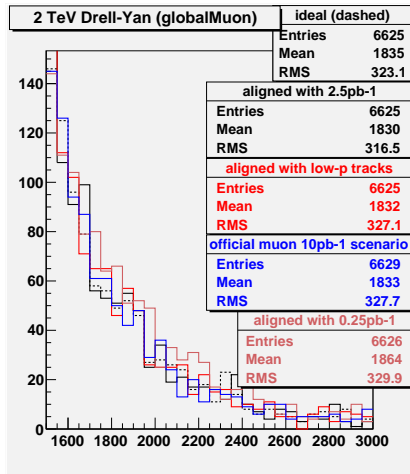
Effect on di-muon resolution

Overlay of 1 TeV Drell-Yan and Z' resonance



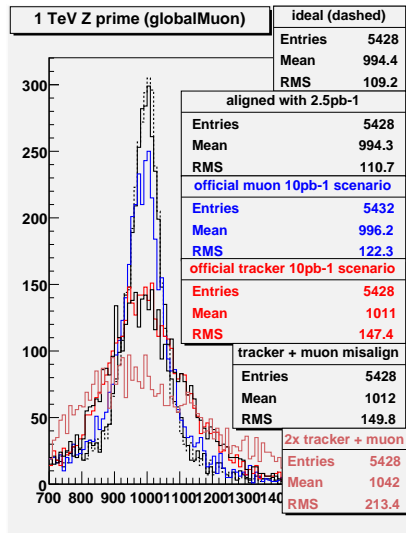
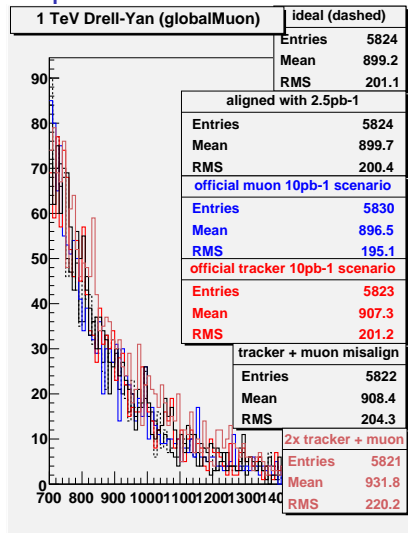
“low-p” means 20-60 GeV $Z \rightarrow \mu\mu$
 official 10 pb⁻¹ scenario is pessimistic

Overlay of 2 TeV Drell-Yan and Z' resonance



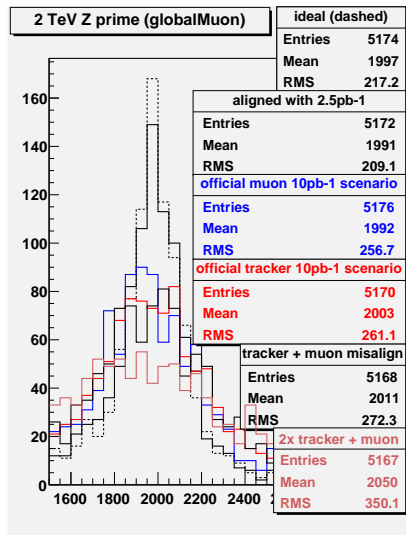
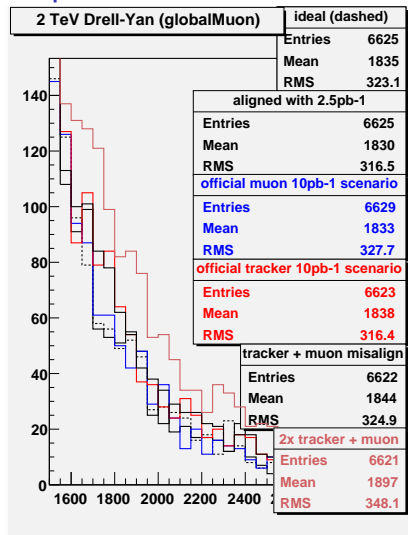
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Comparison with tracker alignment scenario



Careful! Tracker alignment scenario might be pessimistic, too

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Drell-Yan (not) smearing

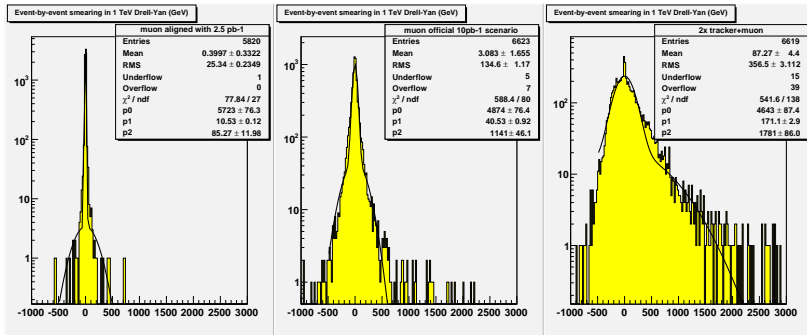
Simple model of Drell-Yan smearing

- ▶ Drell-Yan is exponentially distributed: $f(x) = e^{-kx}$
- ▶ Convoluted: $f(y) = \int f(x) \frac{1}{\sqrt{2\pi}\sigma} \exp\left(\frac{-(x-y)^2}{2\sigma^2}\right) dx$
- ▶ $f(y) = e^{-ky} \exp(\sigma^2 k^2/2)$
- ▶ Convolution kernel is a series: $A_1 e^{x^2/2/\sigma_1^2} + A_2 e^{x^2/2/\sigma_2^2} + \dots$
("tails" are wide Gaussians with small contribution)
- ▶ $f(y) = e^{-ky} (A_1 \exp(\sigma_1^2 k^2/2) + A_2 \exp(\sigma_2^2 k^2/2) + \dots)$
- ▶ Depends linearly on A_i and as $e^{\sigma_i^2}$ on width: could be big!

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- ▶ What's k for Drell-Yan? $k = 6 \times 10^{-3}/\text{GeV}$ (near 1 TeV)
and $3.4 \times 10^{-3}/\text{GeV}$ (near 2 TeV)
- ▶ What's σ ?

Fit Drell-Yan smearing to multi-Gaussian to quantify tail σ s



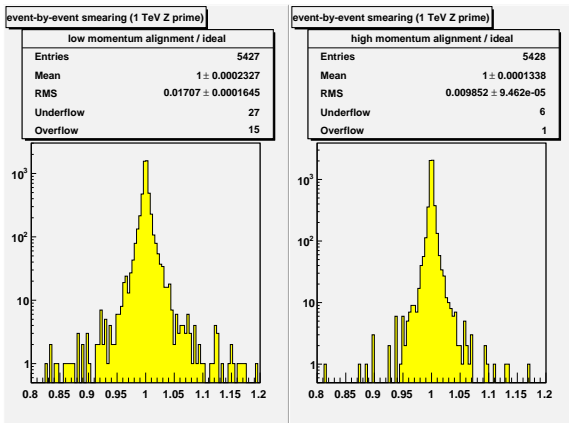
- ▶ Only in $2\times$ tracker misalignment scenario does it become significant: $A_i = 0.07$, $\sigma = 500$ GeV, $A_i e^{\sigma_i^2 k^2 / 2} = 7.3$
- ▶ But smearing in this scenario is negligible ($\lesssim 1.5$): when $\Delta E \sim 500$ GeV, $\sigma \rightarrow \sigma(E)$, less contribution from low-energy
- ▶ Exponential is cut off by $\sigma(E)$ before it can explode



So let's concentrate on
resonance broadening

How much does a misalignment broaden di-muon mass?

RMS of event-by-event $\frac{\text{misaligned di-muon mass}}{\text{ideal di-muon mass}} - 1$



aligned with: $20 < |\vec{p}| < 60 \text{ GeV}$

$|\vec{p}| > 60 \text{ GeV}$

Comparison of alignment scenarios

$$\text{RMS of event-by-event} \frac{\text{misaligned di-muon mass}}{\text{ideal di-muon mass}} - 1$$

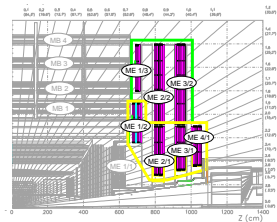
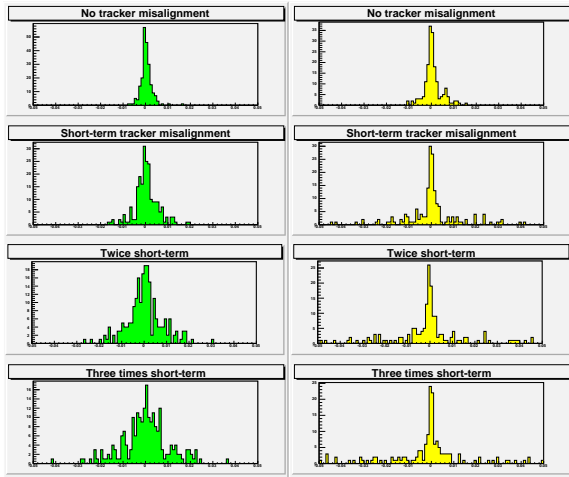
Source of alignment	$Z'(1000)$	$Z'(2000)$	DY(1000)	DY(2000)
1k μ (0.25 pb^{-1})	6.0%	5.5%	4.8%	6.6%
10k μ (2.5 pb^{-1})	1.8%	1.7%	1.6%	2.1%
100k μ (25 pb^{-1})	1.2%	1.1%	1.0%	1.3%
325k μ (82 pb^{-1})	1.0%	1.0%	0.7%	1.2%
$ \vec{p} > 60 \text{ GeV}$	1.0%	1.0%	0.8%	1.2%
$20 < \vec{p} < 60 \text{ GeV}$	1.7%	1.7%	1.5%	2.1%

With this as a bottom line, we can make statements like “switching to $|\vec{p}| > 60 \text{ GeV}$ is as good as getting a factor of ten more tracks.”

Tails in accuracy from tracker misalignment at high η

Outer endcap

Inner endcap

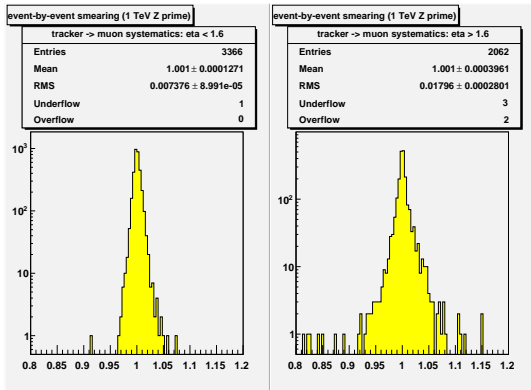


Outer endcap (1/3,
2/2, 3/2) only widens

But inner endcap (1/2,
N/1) gets more outliers



Effect on di-muons



RMS of $\frac{\text{tracker and muon misaligned di-muon mass}}{\text{tracker misaligned di-muon mass}} - 1$

	$Z'(1000)$	$Z'(2000)$	DY(1000)	DY(2000)
Both μ 's in $ \eta < 1.6$	0.7%	0.9%	0.5%	1.0%
One in $ \eta > 1.6$	1.8%	1.5%	1.3%	2.0%

Conclusions

- ▶ Resonance broadening is more significant than Drell-Yan smearing
- ▶ 10 pb^{-1} tracker misalignment *scenario* has more impact on resonance shape (10%) than 10 pb^{-1} muon alignment *scenario* (6%)
- ▶ Effect of muon misalignment scenario is about $4\times$ too pessimistic, including known systematic effects (tracker extrapolation, momentum dependence down to 20 GeV, miscalibration)
- ▶ Systematic error from tracker extrapolation is measurably larger in $|\eta| > 1.6$ (2%) than $|\eta| < 1.6$ (1%).